Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/826,649	KATO, HIDEO	
Examiner	Art Unit	
DANH C. LE	2617	

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Class	Subclass	Date	Examiner
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348	376		
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INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
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Interferen	nce Search	11/30/06	DCL	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Inventor Name Search (Check for double patenting) EAST Search updated (US, USPUB, JPO, EPO DERWENT)	11/30/06	DCI		
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